Silicon Carbide (SiC) Cascode JFET – EliteSiC, Power N-Channel, TO247-4, 650 V, 80 mohm

UF3C065080K4S

Description

onsemi's cascode products co-package its high-performance F3 SiC fast JFETs with a cascode optimized MOSFET to produce the only standard gate drive SiC device in the market today. This series exhibits very fast switching using a 4-terminal TO247- package and the best reverse recovery characteristics of any device of similar ratings. These devices are excellent for switching inductive loads, and any application requiring standard gate drive.

Features

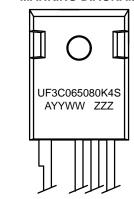
- Typical On-resistance $R_{DS(on)typ}$ of 80 m Ω
- Maximum Operating Temperature of 175 °C
- Excellent Reverse Recovery
- Low Gate Charge
- Low Intrinsic Capacitance
- ESD Protected, HBM Class 2
- TO247-4 Package for Faster Switching, Clean Gate Waveforms
- This Device is Pb-Free, Halogen Free and is ROHS Compliant

Typical Applications

- EV Charging
- PV Inverters
- Switch Mode Power Supplies
- Power Factor Correction Modules
- Motor Drives
- Induction Heating



MARKING DIAGRAM

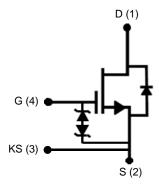


 ${\sf UF3C065080K4S} = {\sf Specific \ Device \ Code}$

A = Assembly Location

YY = Year WW = Work Week ZZZ = Lot ID

PIN CONNECTIONS



ORDERING INFORMATION

See detailed ordering and shipping information on page 8 of this data sheet.

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MAXIMUM RATINGS

Parameter	Symbol	Test Conditions	Value	Unit
Drain-source Voltage	V_{DS}		650	V
Gate-source Voltage	V_{GS}	DC	-25 to +25	V
Continuous Drain Current (Note 1)	I _D	T _C = 25 °C	31	А
		T _C = 100 °C	23	А
Pulsed Drain Current (Note 2)	I _{DM}	T _C = 25 °C	65	А
Single Pulsed Avalanche Energy (Note 3)	E _{AS}	L = 15 mH, I _{AS} = 2.1 A	33	mJ
Power Dissipation	P _{tot}	T _C = 25 °C	190	W
Maximum Junction Temperature	$T_{J,max}$		175	°C
Operating and Storage Temperature	T _J , T _{STG}		-55 to 175	°C
Max. Lead Temperature for Soldering, 1/8" from Case for 5 Seconds	TL		250	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Limited by $T_{J,max}$ 2. Pulse width t_p limited by $T_{J,max}$ 3. Starting $T_J = 25 \, ^{\circ}C$

THERMAL CHARACTERISTICS

Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit
Thermal Resistance, Junction-to-Case	$R_{\theta JC}$		-	0.61	0.79	°C/W

ELECTRICAL CHARACTERISTICS ($T_J = +25$ °C unless otherwise specified)

Parameter	Symbol Test Conditions		Min	Тур	Max	Unit
TYPICAL PERFORMANCE – STATIC						
Drain-source Breakdown Voltage	BV _{DS}	$V_{GS} = 0 \text{ V}, I_D = 1 \text{ mA}$	650	-	-	V
Total Drain Leakage Current	I _{DSS}	V_{DS} = 650 V, V_{GS} = 0 V, T_{J} = 25 °C	-	6	100	μΑ
		$V_{DS} = 650 \text{ V}, V_{GS} = 0 \text{ V}, T_J = 175 ^{\circ}\text{C}$	-	40	-	
Total Gate Leakage Current	I _{GSS}	V _{DS} = 0 V, T _J = 25 °C, V _{GS} = -20 V / +20 V	-	6	±20	μΑ
Drain-source On-resistance	R _{DS(on)}	V_{GS} = 12 V, I_D = 20 A, T_J = 25 °C	-	80	100	mΩ
		$V_{GS} = 12 \text{ V}, I_D = 20 \text{ A}, T_J = 125 ^{\circ}\text{C}$	-	111	-	
		$V_{GS} = 12 \text{ V}, I_D = 20 \text{ A}, T_J = 175 ^{\circ}\text{C}$	-	141	-	
Gate Threshold Voltage	V _{G(th)}	$V_{DS} = 5 \text{ V}, I_{D} = 10 \text{ mA}$	4	5	6	V
Gate Resistance	R_{G}	f = 1 MHz, open drain	-	4.5	-	Ω
TYPICAL PERFORMANCE – REVERSE DIOI	ÞΕ					
Diode Continuous Forward Current (Note 4)	I _S	T _C = 25 °C	-	-	31	Α
Diode Pulse Current (Note 5)	I _{S,pulse}	T _C = 25 °C	-	-	65	Α
Forward Voltage	V _{FSD}	V _{GS} = 0 V, I _S = 10 A, T _J = 25 °C	-	1.5	2	V
		$V_{GS} = 0 \text{ V}, I_{S} = 10 \text{ A}, T_{J} = 175 ^{\circ}\text{C}$	-	1.75	-]
Reverse Recovery Charge	Q _{rr}	$V_{DS} = 400 \text{ V}, I_S = 20 \text{ A}, V_{GS} = -5 \text{ V},$	-	119	-	nC
Reverse Recovery Time	t _{rr}	R_{G_EXT} = 10 Ω, di/dt = 2200 A/μs, T_J = 25 °C	-	16	-	ns
Reverse Recovery Charge	Q _{rr}	$V_{DS} = 400 \text{ V}, I_S = 20 \text{ A}, V_{GS} = -5 \text{ V},$	-	73	-	nC
Reverse Recovery Time	t _{rr}	R_{G_EXT} = 10 Ω, di/dt = 2200 A/μs, T_{J} = 150 °C	-	11	-	ns

ELECTRICAL CHARACTERISTICS (T_J = +25 $^{\circ}$ C unless otherwise specified) (continued)

Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit
TYPICAL PERFORMANCE - DYNAMIC				•		
Input Capacitance	C _{iss}	$V_{DS} = 100 \text{ V}, V_{GS} = 0 \text{ V},$	-	1500	_	pF
Output Capacitance	C _{oss}	f = 100 kHz	-	104	_	
Reverse Transfer Capacitance	C _{rss}]	-	2.6	_	
Effective Output Capacitance, Energy Related	C _{oss(er)}	V _{DS} = 0 V to 400 V, V _{GS} = 0 V	-	77	-	pF
Effective Output Capacitance, Time Related	C _{oss(tr)}	V _{DS} = 0 V to 400 V, V _{GS} = 0 V	-	176	-	pF
C _{OSS} Stored Energy	E _{oss}	V _{DS} = 400 V, V _{GS} = 0 V	-	6.2	-	μJ
Total Gate Charge	Q_{G}	$V_{DS} = 400 \text{ V}, I_{D} = 20 \text{ A},$	-	43	-	nC
Gate-drain Charge	Q_{GD}	$V_{GS} = -5 \text{ V to } 12 \text{ V}$	-	11	-	
Gate-source Charge	Q _{GS}		-	19	-	
Turn-on Delay Time	t _{d(on)}	V _{DS} = 400 V, I _D = 20 A, Gate Driver = -5 V to +12 V.	-	21	-	ns
Rise Time	t _r	Turn-on $R_{G,EXT} = 8.5 \Omega$,	-	20	_	
Turn-off Delay Time	t _{d(off)}	Turn-off $R_{G,EXT} = 20 \Omega$ Inductive Load,	-	37	_	
Fall Time	t _f	FWD: same device with $V_{GS} = -5 \text{ V}$, $R_G = 10 \Omega$, $T_J = 25 ^{\circ}\text{C}$	-	8	_	
Turn-on Energy	E _{ON}	NG = 10 sz, 1j = 25 C	-	121	-	μJ
Turn-off Energy	E _{OFF}		-	41	_	
Total Switching Energy	E _{TOTAL}]	-	162	-	
Turn-on Delay Time	t _{d(on)}	$V_{DS} = 400 \text{ V}, I_{D} = 20 \text{ A},$	-	17	_	ns
Rise Time	t _r	Gate Driver = -5 V to +12 V, Turn-on R _{G,EXT} = 8.5 Ω ,	-	18	_	
Turn-off Delay Time	t _{d(off)}	Turn-off $R_{G,EXT} = 20 \Omega$ Inductive Load.	-	36	-	
Fall Time	t _f	FWD: same device with $V_{GS} = -5 \text{ V}$, $R_G = 10 \Omega$, $T_J = 150 ^{\circ}\text{C}$	-	7	-	
Turn-on Energy	E _{ON}	NG = 10 52, 1J = 130 C	-	107	-	μJ
Turn-off Energy	E _{OFF}		-	31	-	
Total Switching Energy	E _{TOTAL}]	-	138	_	

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. Limited by T_{J,max}

5. Pulse width t_p limited by T_{J,max}

TYPICAL PERFORMANCE DIAGRAMS

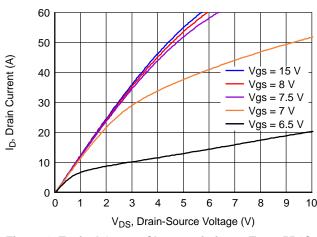


Figure 1. Typical Output Characteristics at T $_J$ = –55 °C, t_p < 250 μs

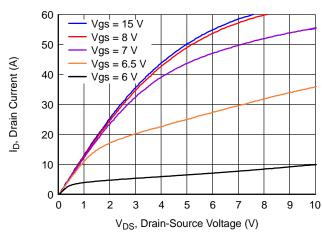


Figure 2. Typical Output Characteristics at T_J = 25 °C, t_n < 250 μs

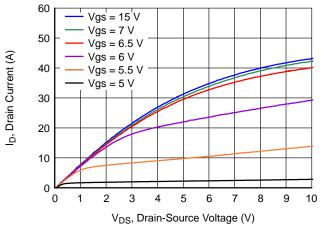


Figure 3. Typical Output Characteristics at T $_{J}$ = 175 °C, t_{p} < 250 μs

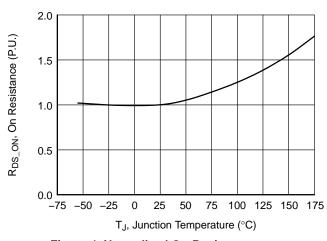


Figure 4. Normalized On-Resistance vs. Temperature at V_{GS} = 12 V and I_D = 20 A

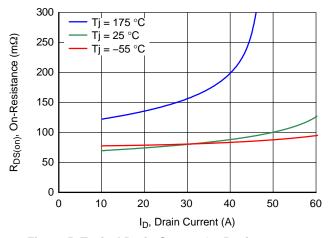


Figure 5. Typical Drain-Source On-Resistances at $V_{GS} = 12 \text{ V}$

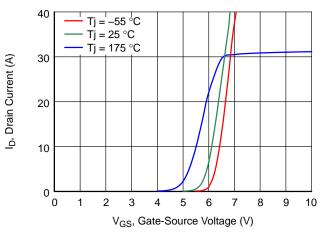


Figure 6. Typical Transfer Characteristics at V_{DS} = 5 V

TYPICAL PERFORMANCE DIAGRAMS (CONTINUED)

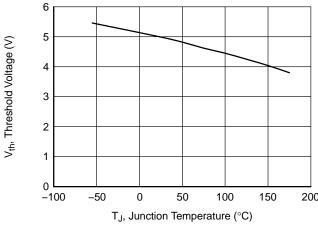


Figure 7. Threshold Voltage vs. Junction Temperature at V_{DS} = 5 V and I_{D} = 10 mA

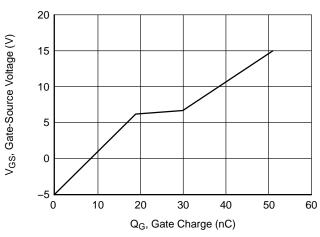


Figure 8. Typical Gate Charge at V_{DS} = 400 V and I_{D} = 20 A

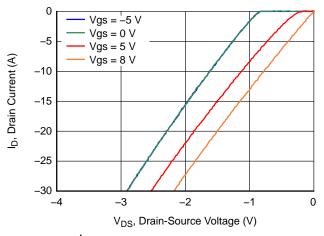


Figure 9. 3^{rd} Quadrant Characteristics at $T_J = -55$ °C

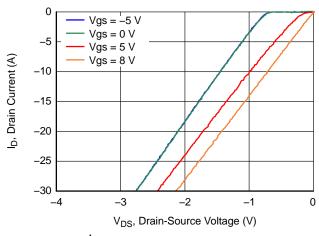


Figure 10. 3rd Quadrant Characteristics at T_J = 25 °C

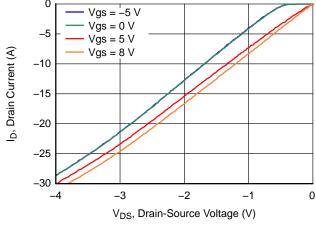


Figure 11. 3rd Quadrant Characteristics at T_J = 175 °C

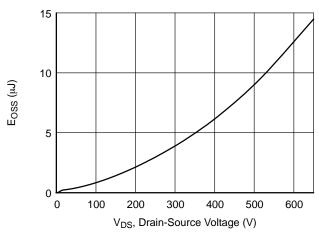


Figure 12. Typical Stored Energy in C_{OSS} at V_{GS} = 0 V

TYPICAL PERFORMANCE DIAGRAMS (CONTINUED)

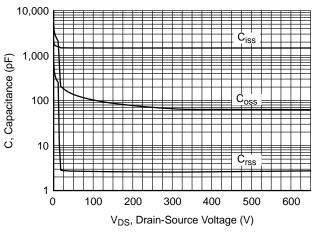


Figure 13. Typical Capacitances at f = 100 kHz and V_{GS} = 0 V

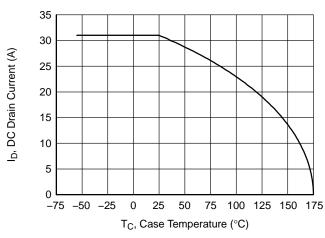


Figure 14. DC Drain Current Derating

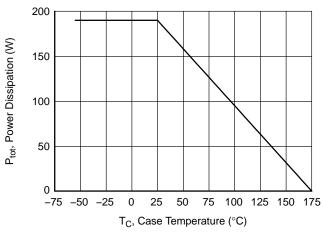


Figure 15. Total Power Dissipation

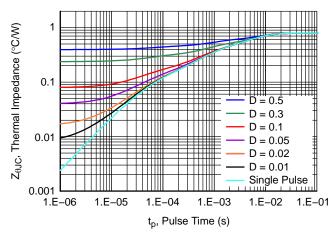


Figure 16. Maximum Transient Thermal Impedance

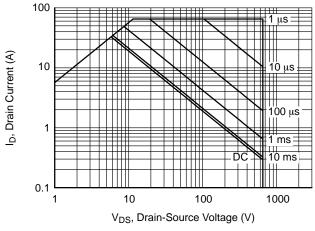


Figure 17. Safe Operation Area at T_C = 25 °C, D = 0, Parameter t_p

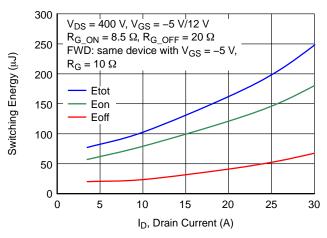


Figure 18. Clamped Inductive Switching Energy vs.

Drain Current at $T_J = 25$ °C

TYPICAL PERFORMANCE DIAGRAMS (CONTINUED)

Q_{rr} (nC)

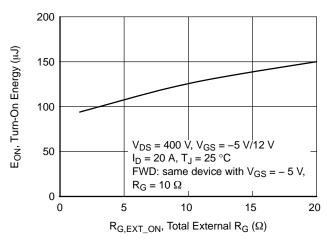


Figure 19. Clamped Inductive Switching Turn-on Energy vs. R_{G,EXT_ON}

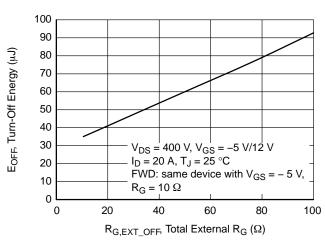


Figure 20. Clamped Inductive Switching Turn-off Energy vs. R_{G,EXT_OFF}

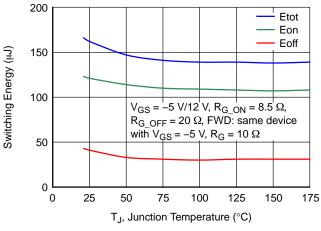


Figure 21. Clamped Inductive Switching Energy vs. Junction Temperature at V_{DS} = 400 V and I_{D} = 20 A

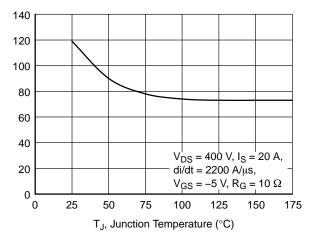


Figure 22. Reverse Recovery Charge Q_{rr} vs. Junction Temperature

APPLICATIONS INFORMATION

SiC cascodes are enhancement-mode power switches formed by a high-voltage SiC depletion-mode JFET and a low-voltage silicon MOSFET connected in series. The silicon MOSFET serves as the control unit while the SiC JFET provides high voltage blocking in the off state. This combination of devices in a single package provides compatibility with standard gate drivers and offers superior performance in terms of low on-resistance ($R_{DS(on)}$), output capacitance (C_{oss}), gate charge (Q_G), and reverse recovery charge (Q_{T}) leading to low conduction and switching losses.

The SiC cascodes also provide excellent reverse conduction capability eliminating the need for an external anti-parallel diode

Like other high performance power switches, proper PCB layout design to minimize circuit parasitics is strongly recommended due to the high dv/dt and di/dt rates. An external gate resistor is recommended when the cascode is working in the diode mode in order to achieve the optimum reverse recovery performance. For more information on cascode operation, see www.onsemi.com.

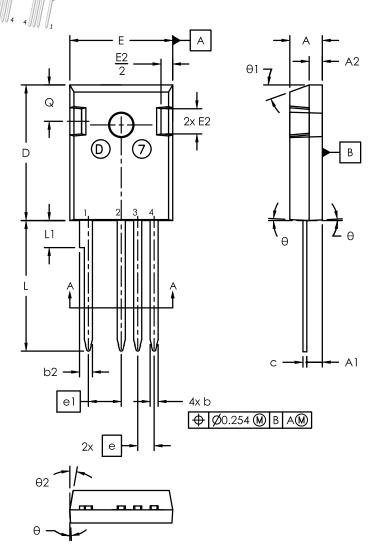
ORDERING INFORMATION

Part Number	Marking	Package	Shipping [†]
UF3C065080K4S	UF3C065080K4S	TO247-4 15.90x20.96x5.03, 5.44P (Pb-Free, Halogen Free)	600 / Tube





DATE 20 JUN 2025



♦ Ø0.635 M B	A(M)
ØP $\overline{\ \ }$	₽ D2
\$	D1
ØP1 4 3 2 1	<u> </u>
	- E1 - E1

SYM	1	millimeter	S		
317/1	MIN	NOM	MAX		
Α	4.70	5.03	5.31		
A1	2.21	2.40	2.59		
A2	1.50	2.03	2.49		
b	0.99	1.20	1.40		
b2	1.65	2.03	2.39		
С	0.38	0.60	0.89		
D	20.80	20.96	21.46		
D1	13.08	_	_		
D2	0.51	1.19	1.35		
Е	15.49	15.90	16.26		
e	2.54 BSC				
el		5.08 BSC			
E1	13.46	-	-		
E2	3.43	3.89	5.20		
Ш	19.81	20.17	20.32		
L1	_	_	4.50		
ØP	3.40	3.60	3.80		
ØP1	7.06	7.19	7.39		
Q	5.38	5.62	6.20		
S	6.17 BSC				
θ	3°				
θ1	20°				
θ2	10°				

NOTE:

- 1. Dimensioning and tolerancing as per ASME Y14.5 2018
- 2. Controlling dimension: millimeters
- 3. Package Outline in compliance with JEDEC standard var.
- 4. Dimensions D & E does not include mold flash.
- 5. ØP to have max draft angle of 1.7° to the top with max. hole diameter of 3.91mm.
- 5. Through Hole diameter value = End Hole diameter
- 6. PCB Through Hole pattern as per IPC-2221/IPC-2222

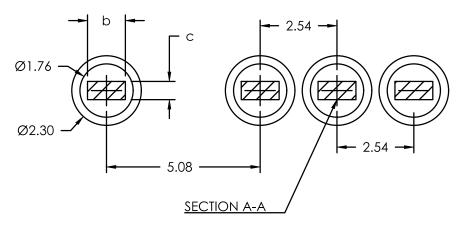
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DATE 20 JUN 2025

RECOMMENDED PCB THROUGH HOLE



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